SFH 4647

MIDLED®

Narrow beam LED in MIDLED package (940 nm)







Applications

Gesture Recognition

- Remote Control, Proximity, Ambient Light Sensing

Features:

- Package: clear silicone
- Qualifications: The product qualification test plan is based on the guidelines of AEC-Q101-REV-C, Stress Test Qualification for Automotive Grade Discrete Semiconductors.
- ESD: 2 kV acc. to ANSI/ESDA/JEDEC JS-001 (HBM, Class 2)
- Wavelength 950nm
- High Power Infrared LED (65 mW)
- Short switching times
- Narrow half angle (± 15°)
- Low profile component
- Sidelooker

Ordering Information

Туре	Radiant intensity 1)	Radiant intensity 1)	Ordering Code
	$I_F = 100 \text{ mA}; t_p = 20 \text{ ms}$	typ. $I_F = 100 \text{ mA}; t_p = 20 \text{ ms}$	
	l _e	l _e	
SFH 4647	40 200 mW/sr	90 mW/sr	Q65111A6207



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$T_{\Lambda} = 25 ^{\circ}$)
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Parameter	Symbol		Values
Operating temperature	T _{op}	min.	-40 °C
	űp.	max.	100 °C
Storage temperature	T _{stg}	min.	-40 °C
	otg	max.	100 °C
Forward current	I _F	max.	100 mA
Surge current	I	max.	1 A
$t_p \le 100 \mu\text{s}; D = 0$	1 0.00		
Reverse voltage ²⁾	V_R	max.	12 V
Power consumption	P _{tot}	max.	190 mW
ESD withstand voltage	V _{ESD}	max.	2 kV
acc. to ANSI/ESDA/JEDEC JS-001 (HBM, Class 2)	LOD		



Characteristics

 $I_{_{\rm F}}$ = 100 mA; $t_{_{
m p}}$ = 20 ms; $T_{_{
m A}}$ = 25 °C

Parameter	Symbol		Values
Peak wavelength	$\lambda_{\sf peak}$	typ.	950 nm
Centroid wavelength	$\lambda_{ ext{centroid}}$	typ.	940 nm
Spectral bandwidth at 50% I _{rel,max}	Δλ	typ.	42 nm
Half angle	φ	typ.	15 °
Dimensions of active chip area	LxW	typ.	0.3 x 0.3 mm x mm
Rise time (10% / 90%) $I_F = 100 \text{ mA}; R_L = 50 \Omega$	t _r	typ.	12 ns
Fall time (10% / 90%) $I_F = 100 \text{ mA}; R_L = 50 \Omega$	t _f	typ.	12 ns
Forward voltage	V_{F}	typ. max.	1.6 V 1.9 V
Forward voltage $I_F = 1 \text{ A}; t_p = 100 \mu\text{s}$	V_{F}	typ. max.	3.6 V 4.6 V
Reverse current ²⁾ V _R = 5 V	I _R	max. typ.	10 μA 0.01 μA
Radiant intensity ¹⁾ $I_F = 1 \text{ A}; t_p = 100 \mu\text{s}$	l _e	typ.	375 mW/sr
Total radiant flux 3)	Фе	typ.	65 mW
Temperature coefficient of voltage	TC_v	typ.	-0.8 mV / K
Temperature coefficient of brightness	TC _I	typ.	-0.3 % / K
Temperature coefficient of wavelength	TC_{λ}	typ.	0.3 nm / K
Thermal resistance junction solder point real 4)	R_{thJS}	max.	180 K / W
Thermal resistance junction ambient real 5)	R_{thJA}	max.	340 K / W



Brightness Groups

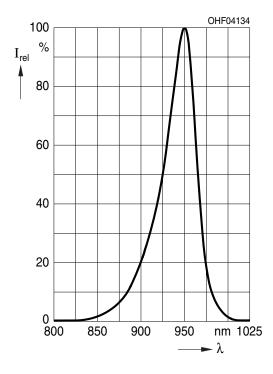
 $T_A = 25 \, ^{\circ}C$

Group	Radiant intensity $I_F = 100 \text{ mA}$; $t_p = 20 \text{ ms}$ min. I_e	Radiant intensity $I_F = 100 \text{ mA}$; $t_p = 20 \text{ ms}$ max. I_e
U	40 mW/sr	80 mW/sr
V	63 mW/sr	125 mW/sr
AW	100 mW/sr	200 mW/sr

Only one group in one packing unit (variation lower 2:1).

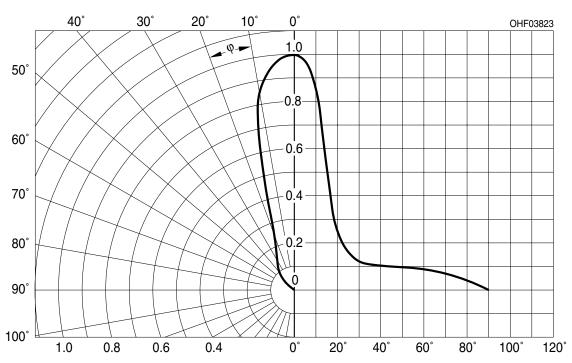
Relative Spectral Emission 6), 7)

$$I_{rel} = f(\lambda); I_{F} = 100 \text{ mA}; t_{p} = 20 \text{ ms}$$



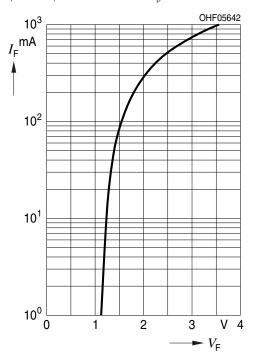
Radiation Characteristics 6), 7)





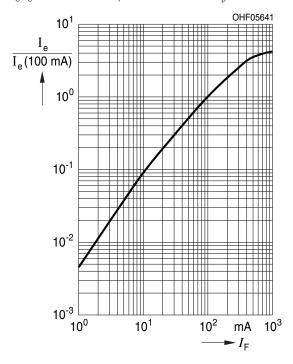
Forward current 6), 7)

 $I_F = f(V_F)$; single pulse; $t_p = 100 \mu s$



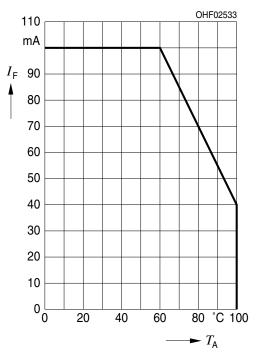
Relative Radiant Intensity 6), 7)

 I_e/I_e (100mA) = f (I_F); single pulse; t_p = 100 μs



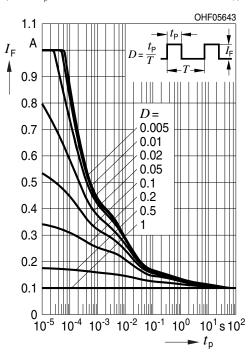
Max. Permissible Forward Current

$$I_{F,max} = f(T_A); R_{thJA} = 340 \text{ K} / \text{W}$$

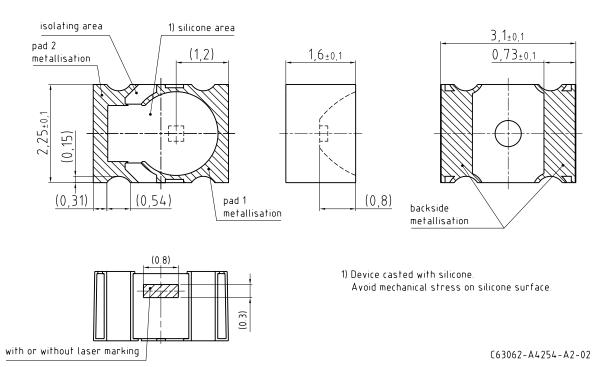


Permissible Pulse Handling Capability

 $I_F = f(t_p)$; duty cycle D = parameter; $T_A = 25$ °C



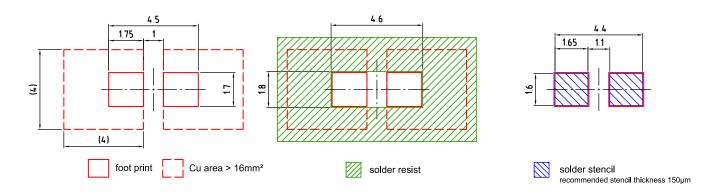
Dimensional Drawing 8)



Approximate Weight: 23.0 mg

Pin	Description	
1	Anode	
2	Cathode	

Recommended Solder Pad 8)



Component Location on Pad

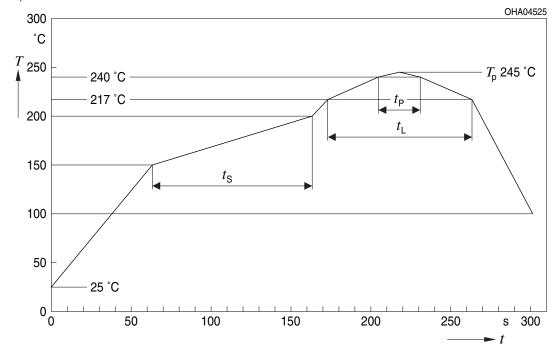


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Pad 1: anode

Reflow Soldering Profile

Product complies to MSL Level 2 acc. to JEDEC J-STD-020E

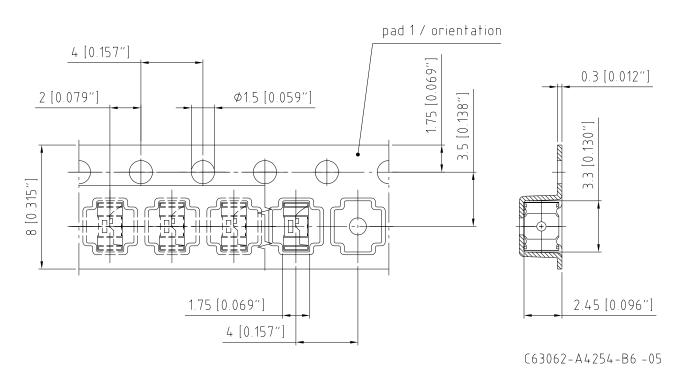


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Profile Feature	Symbol	Pb	-Free (SnAgCu) Ass	sembly	Unit
	,	Minimum	Recommendation	Maximum	
Ramp-up rate to preheat*) 25 °C to 150 °C			2	3	K/s
Time t_s T_{Smin} to T_{Smax}	t _s	60	100	120	S
Ramp-up rate to peak*) T_{Smax} to T_{P}			2	3	K/s
Liquidus temperature	T_L		217		°C
Time above liquidus temperature	t_		80	100	S
Peak temperature	T _P		245	260	°C
Time within 5 °C of the specified peak temperature T _P - 5 K	t _P	10	20	30	S
Ramp-down rate* T _p to 100 °C			3	6	K/s
Time 25 °C to T _P				480	S

All temperatures refer to the center of the package, measured on the top of the component

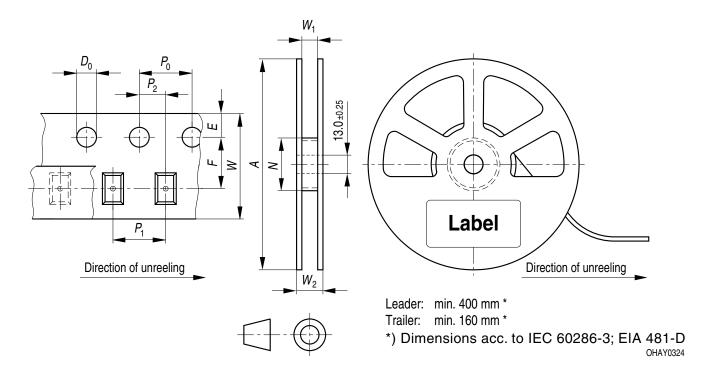
Taping 8)





^{*} slope calculation DT/Dt: Dt max. 5 s; fulfillment for the whole T-range

Tape and Reel 9)

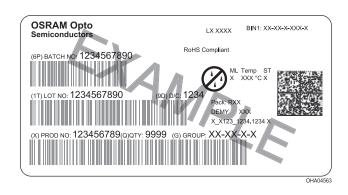


Reel dimensions [mm]

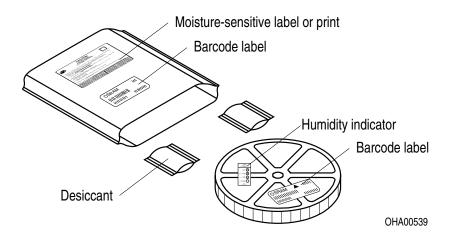
A	W	N_{min}	W ₁	$W_{2 max}$	Pieces per PU
180 mm	8 + 0.3 / - 0.1	60	8.4 + 2	14.4	2000



Barcode-Product-Label (BPL)



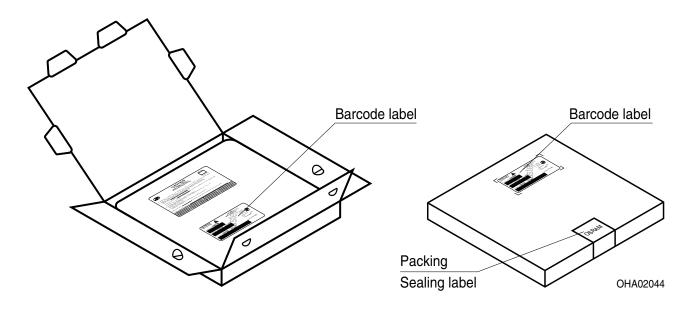
Dry Packing Process and Materials 8)



Moisture-sensitive product is packed in a dry bag containing desiccant and a humidity card according JEDEC-STD-033.



Transportation Packing and Materials 8)



Dimensions of transportation box in mm

Width	Length	Height
200 ± 5 mm	195 ± 5 mm	30 ± 5 mm



Notes

The evaluation of eye safety occurs according to the standard IEC 62471:2006 (photo biological safety of lamps and lamp systems). Within the risk grouping system of this IEC standard, the device specified in this data sheet falls into the class **exempt group (exposure time 10000 s)**. Under real circumstances (for exposure time, conditions of the eye pupils, observation distance), it is assumed that no endangerment to the eye exists from these devices. As a matter of principle, however, it should be mentioned that intense light sources have a high secondary exposure potential due to their blinding effect. When looking at bright light sources (e.g. headlights), temporary reduction in visual acuity and afterimages can occur, leading to irritation, annoyance, visual impairment, and even accidents, depending on the situation.

Subcomponents of this device contain, in addition to other substances, metal filled materials including silver. Metal filled materials can be affected by environments that contain traces of aggressive substances. Therefore, we recommend that customers minimize device exposure to aggressive substances during storage, production, and use. Devices that showed visible discoloration when tested using the described tests above did show no performance deviations within failure limits during the stated test duration. Respective failure limits are described in the IEC60810.

For further application related informations please visit www.osram-os.com/appnotes



Disclaimer

Disclaimer

Language english will prevail in case of any discrepancies or deviations between the two language wordings.

Attention please!

The information describes the type of component and shall not be considered as assured characteristics. Terms of delivery and rights to change design reserved. Due to technical requirements components may contain dangerous substances.

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Packing

Please use the recycling operators known to you. We can also help you – get in touch with your nearest sales office.

By agreement we will take packing material back, if it is sorted. You must bear the costs of transport. For packing material that is returned to us unsorted or which we are not obliged to accept, we shall have to invoice you for any costs incurred.

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Glossary

- Radiant intensity: Measured at a solid angle of Ω = 0.01 sr
- ²⁾ **Reverse Operation**: Reverse Operation of 10 hours is permissible in total. Continuous reverse operation is not allowed.
- Total radiant flux: Measured with integrating sphere.
- Thermal resistance: junction soldering point, of the device only, mounted on an ideal heatsink (e.g. metal block)
- Thermal resistance: junction ambient, mounted on PC-board (FR4), padsize 16 mm² each
- Typical Values: Due to the special conditions of the manufacturing processes of semiconductor devices, the typical data or calculated correlations of technical parameters can only reflect statistical figures. These do not necessarily correspond to the actual parameters of each single product, which could differ from the typical data and calculated correlations or the typical characteristic line. If requested, e.g. because of technical improvements, these typ. data will be changed without any further notice.
- Testing temperature: $T_A = 25^{\circ}C$
- Tolerance of Measure: Unless otherwise noted in drawing, tolerances are specified with ±0.1 and dimensions are specified in mm.
- ⁹⁾ **Tape and Reel**: All dimensions and tolerances are specified acc. IEC 60286-3 and specified in mm.



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